Unit: mm

TOSHIBA Field Effect Transistor Silicon P Channel MOS Type ($L^2-\pi$ -MOSV)

2SJ465

DC-DC Converter, Relay Drive and Motor Drive Applications

• 2.5-V gate drive

• Low drain-source ON resistance : $RDS(ON) = 0.54 \Omega \text{ (typ.)}$

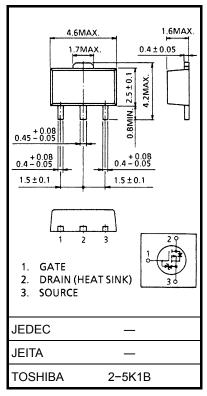
• High forward transfer admittance : $|Y_{fs}| = 1.7 \text{ S (typ.)}$

• Low leakage current : $IDSS = -100 \mu A (max) (VDS = -16 V)$

• Enhancement mode : V_{th} = -0.5~-1.1 V (V_{DS} = -10 V, I_{D} = -200 μA)

Absolute Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	
Drain-source voltage		V_{DSS}	-16	V	
Drain-gate voltage (R _{GS} = 20 kΩ)		V_{DGR}	-16	V	
Gate-source voltage		V_{GSS}	±8	V	
Drain current	DC (Note 1)	ΙD	-2	Α	
	Pulse (Note 1)	I _{DP}	-6	A	
Drain power dissipation	١	P_{D}	0.5	W	
Drain power dissipation (Note 2)		P_{D}	1.5	W	
Channel temperature		T _{ch}	150	°C	
Storage temperature range		T _{stg}	-55~150	°C	



Weight: 0.05 g (typ.)

- Note 1: Ensure that the channel temperature does not exceed 150°C.
- Note 2: Mounted on a ceramic substrate (25.4 mm × 25.4 mm × 0.8 mm)
- Note 3: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to ambient	R _{th (ch-a)}	250	°C/W

This transistor is an electrostatic-sensitive device.

Please handle with caution.



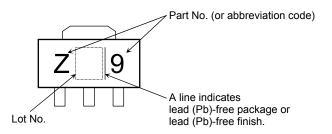
Electrical Characteristics (Ta = 25°C)

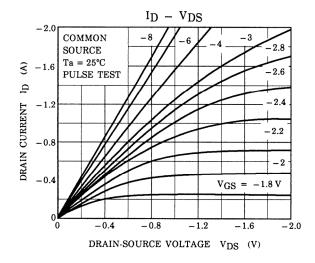
Charac	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	ırrent	I _{GSS}	V _{GS} = ±6.5 V, V _{DS} = 0 V	_	_	±10	μA
Drain cut-off cu	rrent	I _{DSS}	V _{DS} = -16 V, V _{GS} = 0 V	_	_	-100	μΑ
Drain-source br voltage	eakdown	V (BR) DSS	I _D = -10 mA, V _{GS} = 0 V	-16	_	_	V
Gate threshold	/oltage	V _{th}	$V_{DS} = -10 \text{ V}, I_D = -200 \mu\text{A}$	-0.5	_	-1.1	V
Drain assuras ON resistars		Pro (OVI)	$V_{GS} = -2.5 \text{ V}, I_D = -0.5 \text{ A}$	_	0.86	1.0	Ω
Drain-source ON resistance	R _{DS} (ON)	$V_{GS} = -4 \text{ V}, I_D = -1 \text{ A}$	_	0.54	0.71		
Forward transfe	r admittance	Y _{fs}	V _{DS} = -10 V, I _D = -1 A	0.8	1.7	_	S
Input capacitano	ce	C _{iss}		_	270	_	
Reverse transfer capacitance		C _{rss}	V _{DS} = -10 V, V _{GS} = 0 V, f = 1 MHz	_	25	_	pF
Output capacitance		C _{oss}		_	115	_	
Switching time	Rise time	t _r	$V_{GS} \xrightarrow{0V} I_{D} = -1A \\ V_{OUT}$ $R_{L} = 8\Omega$ $V_{DD} = -8V$	_	200	_	
	Turn-on time	t _{on}		_	250	_	ne
	Fall time	t _f		_	200	_	ns ns
	Turn-off time	t _{off}	Duty $\leq 1\%$, $t_{\mathbf{w}} = 10 \mu s$	_	500	_	
Total gate charge (Gate-source plus gate-drain)		Qg			5		
Gate-source charge		Q _{gs}	$V_{DD} \approx -16 \text{ V}, V_{GS} = -5 \text{ V}, I_D = -2 \text{ A}$		3.2		nC
Gate-drain ("miller") charge		Q _{gd}		_	1.8	_	

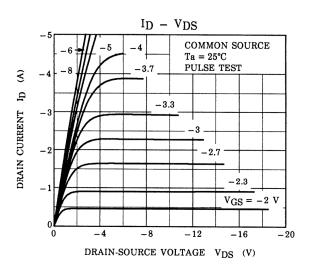
Source-Drain Ratings and Characteristics (Ta = 25°C)

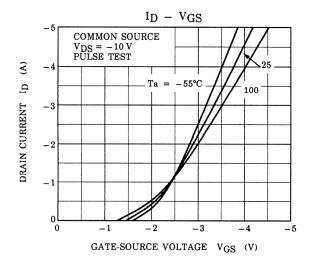
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	_	_	_	-2	Α
Pulse drain reverse current (Note 1)	I _{DRP}	_	_	_	-6	Α
Forward voltage (diode)	V _{DSF}	I _{DR} = -2 A, V _{GS} = 0 V	_	_	1.7	V
Reverse recovery time	t _{rr}	I _{DR} = -2 A, V _{GS} = 0 V		130	_	ns
Reverse recovery charge	Q _{rr}	dl _{DR} / dt = 50 Å / μs	_	0.13	_	μC

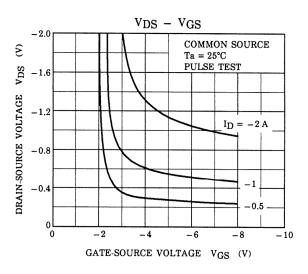
Marking

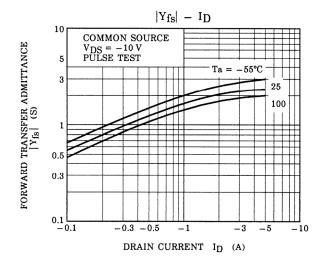


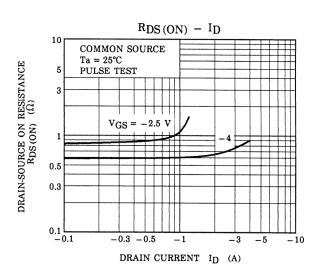




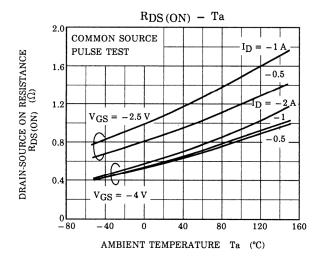


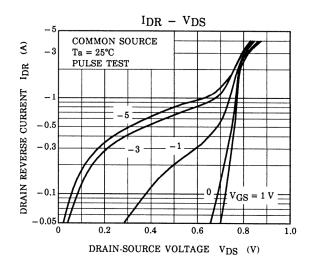


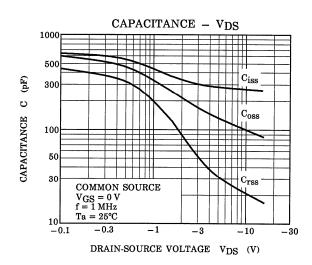


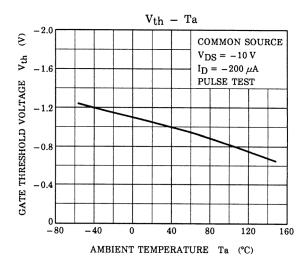


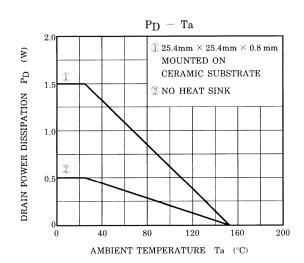
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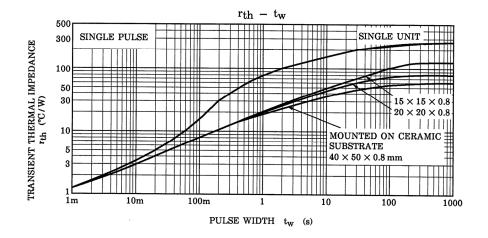


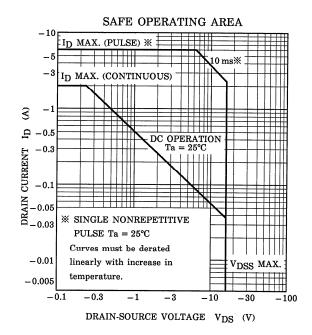






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